## Search Notes



pplication/Control No.	Applicant(s)/Patent under Reexamination

10/624,404 Examiner Reexamination
CROUCH ET AL.
Art Unit

MARK A. MAIS

2619

SEARCHED					
Class	Subclass	Date	Examiner		
370	351-360	4/10/2008	МАМ		

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
			1	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
See Attached Electronic Search	3/4/2007	MAM		
See Inventorship Search	3/4/2007	MAM		
See Attached Electronic Search [updated]	8/7/2007	MAM		
See Attached Electronic Search [updated]	4/10/2008	MAM		